


IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IFW

Applicant(s): ITO et al.		Atty. Dkt.: 24-012-TB-RCE
Serial No.: 10/780,893		Group Art Unit: 2839
Filed: February 19, 2004		Examiner: Prasad, Chandrika
Title: ELECTRONIC COMPONENT HANDLER WITH TEST TRAY AND INSERTS FOR HOLDING ELECTRONIC COMPONENTS IN TEST TRAY		

Commissioner for Patents  
Alexandria, VA 22314

Date: May 10, 2007

**INFORMATION DISCLOSURE STATEMENT**

Sir:

Pursuant to 37 C.F.R. §1.56, the references listed on the attached Form PTO-1449 are submitted for consideration by the Examiner.

The Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed references have been considered and made of record.

Since a first Office Action on the merits has been mailed in the above identified application, the fee due under 37 C.F.R. 1.17(p) of \$180 is enclosed. Please charge any additional fees to Applicant's attorney's Deposit Account No. 50-1147.

Although a final rejection has been issued, the finality of that rejection was improper and has been contested in the amendment filed on 7 May 2007. Therefore, this IDS is considered to be filed prior to a final rejection and should be considered.

Respectfully submitted,

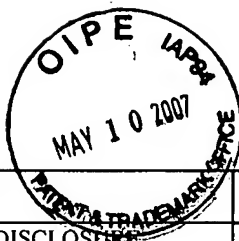
  
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## PATENT APPLICATION

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FORM PTO-1449	ATTY. DKT NO.	24-012-TB	SER. NO.	10/780,893
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT	ITO et al.		
	FILING DATE	2/19/2004	GROUP	2839

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

## FOREIGN PATENT DOCUMENTS

## TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract
		JP-A-11-287842	10/19/99	JAPAN						X
		JP-A-2001-33519	2/9/01	JAPAN						X

\* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

		International Search Report from Japanese Patent Office mailed on December 3, 2002.
EXAMINER	DATE CONSIDERED	